Laboratory Accreditation Programmes

Schedule to

CERTIFICATE OF ACCREDITATION

Laboratory	Callaghan Innovation Measurement Standards Laboratory of New Zealand
Address	PO Box 31310, Lower Hutt, 5040 69 Gracefield Road, Gracefield, Lower Hutt, 5010
Telephone	04 931-3000
Fax	04 931-3117
URL	http://www.measurement.govt.nz/
Authorised Representative	Dr Blair Hall Quality Manager
Client No.	8
Programme	Metrology & Calibration Laboratory
Accreditation Number	1
Initial Accreditation Date	30 July 2004
Conformance Standard	NZS ISO/IEC 17025:2005 General requirements for the competence of testing and calibration laboratories
Testing Services Summary	5.01 Engineers' Limit Gauges 5.02 Jigs, Fixtures, Cutting Tools and Components 5.04 Machine Tools 5.05 Geometric Form 5.11 Working Standards of Length and Angle 5.12 Precision Measuring Instruments 5.14 Laser Frequency 5.21 Masses 5.31 Volumetric Equipment 5.32 Density 5.33 Hydrometers 5.35 Hygrometry 5.41 Barometers 5.42 Differential Pressure Measuring Devices (including Manometers) 5.43 Pressure Gauge Testers and Pressure Balances 5.44 Pressure and Vacuum Measurement 5.61 Temperature Measuring Equipment 5.65 Photometers and Radiometers 5.66 Lamps, LEDs, Lasers and Other Light Sources 5.67 Colour of Light Sources and Colorimeters 5.68 Optical Properties of Materials: Spectral 5.69 Optical Properties of Materials: Spectrally integrated 5.70 Optical Instruments

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	5.82	Resistors, Resistance Boxes and Potential Dividers
	5.84	Capacitors
	5.85	Inductors and Transformers
	5.86	Voltage Standards and Current Standards
	5.87	Transfer Instruments (AC/DC)
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	5.93	Signal Sources
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	5.97	High Voltage Testing

Signatories

Dr Tim Armstrong	5.91, 5.92(a)(c), 5.93(a)
Dr Laurie Christian	5.82, 5.85(d), 5.86, 5.87, 5.88, 5.89, 5.90, 5.92(b), 5.93(b), 5.97
Dr Mark Clarkson	5.41, 5.42, 5.43, 5.44
Mr David Cochrane	5.05(d)(ii), 5.70
Dr Adam Dunford	5.91(a)(c)(d)(g), 5.92(a)(c), 5.93(a)
Dr Murray Early	5.82, 5.86, 5.87, 5.88, 5.89(a)(b)(c)(d)(i), 5.90(a)(f)(g), 5.92(b), 5.93(b), 5.97
Mr Hamish Edgar	5.61
Dr Lucy Forde	5.02, 5.04, 5.11(f)(i)(n), 5.12, 5.14
Dr Blair Hall	5.93(b), 5.95
Mr John Hamlin	5.65, 5.66, 5.67, 5.68, 5.69
Ms Eleanor Howick	5.01, 5.02, 5.04, 5.05, 5.11, 5.12, 5.14
Mr Darrin Jack	5.41, 5.42, 5.43, 5.44
Mr Graeme Jonas	5.05(d)(ii), 5.70
Mr Keith Jones	5.82, 5.84, 5.85, 5.86, 5.88(a)(c)(e), 5.89(a)(c)(e)(f)(i)(l), 5.90, 5.97
Dr Annette Koo	5.68, 5.69
Dr Jeremy Lovell-Smith	5.35
Mr Ross Mason	5.35, 5.61(c)
Mr Greg Reid	5.21, 5.31, 5.32, 5.33
Dr Peter Saunders	5.61, 5.82(a), 5.90(a)(c)
Dr Francois Shindo	5.65, 5.66, 5.67
Mr Tom Stewart	5.84(a)(c), 5.85(a), 5.88(b)(d)(e)(f))(power frequencies only), 5.89(b)(d)(e)(f)(g)(h)(l) (power frequencies only), 5.90(c)
Dr Chris Sutton	5.21, 5.31, 5.32, 5.33, 5.41, 5.42, 5.43, 5.44
Mr Neil Swift	5.65, 5.66, 5.67
Dr David Rodney White	5.35, 5.61, 5.82(a), 5.90(a)(c)
Mr Chris Young	5.01, 5.02, 5.04, 5.05, 5.11, 5.12, 5.14

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The uncertainty of measurement is reported as an expanded uncertainty having a level of confidence of at least 95%, unless stated otherwise. Calibrations are generally performed at the premises of the accredited laboratory, although some may be carried out in the field and some at customer premises.

Measurand	Conditions	Least uncertainty of measurement

5.01 Engineers' Limit Gauges

(a) Plain plug, ring and gap gauges. Taper plug and ring gauges.

Setting plug gauges by comparison with gauge blocks

Mean diameter	0.5 mm to 25 mm	Q(130, 1.4*L*) nm, *L* in mm
Mean diameter	25 mm to 300 mm	Q(95, 1.8*L*) nm, *L* in mm

Setting ring gauges by comparison with gauge blocks

Mean diameter	1 mm to 300 mm	Q(95, 1.8*L*) nm, *L* in mm

Where $Q(a,b) = \sqrt{a^2 + b^2}$

(e) Position and receiver gauges involving both linear and angular measurements.

Lobster tail gauges	54 mm to 60 mm	0.01 mm

(g) Other gauges involving measurements similar to those under (a) and including depth gauges, height gauges and gauges involving plane coordinated position of holes and spigots.

Step gauge face spacing by comparison with end standards on CMM

90 mm to 700 mm	Q(0.7, 1.2 x 10^{-3}*L*) µm, *L* in mm

2D CMM artefacts (ball plate centre coordinates) by comparison with end standards on CMM

Side length between 100 mm and 600 mm	Q(0.9, 1.3 x 10^{-3}*L)* µm, *L* in mm

5.02 Jigs, Fixtures, Cutting Tools and Components

Measurement of components/objects on CMM

Error of indicated size	1 mm to 800 mm	(1.2 + *L*/400) µm, *L* in mm

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5.04 Machine Tools

(b) Practical tests including:

Levelling of dynamic weigh station sites by measurement of deviation from a horizontal plane (calibration carried out on site)

Deviation in height	Horizontal range	
	1.8 m to 60 m	0.3 mm

5.05 Geometric Form

(b) Roundness

Variability in roundness	Range of diameters	
0 µm to 400 µm	1 mm to 300 mm	Q(0.14, 0.05*R*) µm, *R* in µm

(d) Flatness of Optical Flat, Parallelism, Wedge Angle of Optical Wedge or Flat

i) Length section

Parallelism	Range of diameters	
0 µm to 10 µm	10 mm to 35 mm	0.08 µm

Flatness	Range of diameters	
0 µm to 2.5 µm	10 mm to 35 mm	0.06 µm

ii) Photometry section

Flatness of optical flats, one-axis or whole surface

Up to 150 mm diameter (excluding 10 mm closest to rim)	22 nm
Up to 250 mm diameter (excluding 10 mm closest to rim)	33 nm
For outer 10 mm	110 nm

5.11 Working Standards of Length and Angle

(a) Gauge blocks and accessories

Measurement of central length

By interferometry	0.5 mm to 103 mm	Q(17, 0.15*L*) nm, *L* in mm

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By comparison	0.1 mm to 103 mm	Q(36, 1.4*L*) nm, *L* in mm
Measurement of variation in length		Q(30, 0.35*L*) nm, *L* in mm
(b) Length bars and accessories		
Measurement of central length and variation in length		
Long gauge blocks by comparison with gauge blocks using the Horizontal Federal		
100 mm to 300 mm		Q(91, 1.3*L*) nm, *L* in mm
Measurement of variation in length		Q(34, 0.35*L*) nm, *L* in mm
Long gauge blocks by comparison with gauge blocks using the LBC		
100 mm to 1500 mm		Q(370, 0.48*L*) nm, *L* in mm
Measurement of variation in length		100 nm
(f) Precision linear scales		
Engineer or machinist scale-line spacing		
0.1 m to 4 m		Q(10, 8.2*L*) µm, *L* in m
(h) Precision graticules including stage micrometers and haemocytometer counting chambers		
1 µm to 10 mm		0.5 µm
(i) Surveying tapes and petroleum dip tapes		
4 m to 50 m		Q(10, 10.5*L*) µm, *L* in m
Surveyor levelling rods		
0.5 m to 3 m		Q(10, 10*L*) µm, *L* in m
(n) Geodetic Baselines (calibrations carried out on site)		
Interval distances	2 m to 1500 m	Q(0.3, 0.6 x 10^{-3}*L*) mm, *L* in m

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5.12 Precision Measuring Instruments

(a) Length measuring machines

Electronic distance measuring machines (EDMs)

Error of indicated displacement	1 m to 206 m	Q(0.13, 7 x $10^{-4}L$) mm, L in m
Error of indicated frequency	5 MHz to 100 MHz	0.16 x $10^{-6}L$ x frequency
Error of prism constant		0.26 mm

5.14 Laser Frequency

(a) Stabilised lasers of the mise en pratique

Absolute frequency	473 612 GHz	25 kHz

(b) Other stabilised lasers

Absolute frequency	473 612 GHz	0.2 MHz

5.21 Masses

(a) Examination of laboratory standards of mass
(b) Examination of industrial standards of mass
(c) Determination of the mass of solid objects

1 mg to 100 mg	0.4 µg to 0.7 µg
0.1 g to 1 g	0.7 µg to 1.6 µg
1 g to 10 g	1.6 µg to 4 µg
10 g to 100 g	4 µg to 8 µg
0.1 kg to 1 kg	8 µg to 40 µg
1 kg to 10 kg	1.1 x 10^{-7}
10 kg to 20 kg	1.6 x 10^{-7}
20 kg to 300 kg	1.5 x 10^{-6}
300 kg to 1000 kg	10 g to 16 g

5.31 Volumetric Equipment

(a) Examination of laboratory volumetric glassware including examination for compliance with the Class A or Class B requirements of the relevant national or international

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	standards	
0.02 mL to 2 mL		0.0002 mL
(b)	Examination of other types of volumetric apparatus	
0.002 L to 50 L		0.01 %

5.32 Density

(a)	Density of solids	
1400 kg/m^3 to 3000 kg/m^3		1.0 x 10^{-5}
7800 kg/m^3 to 8200 kg/m^3		1.5 x 10^{-5}
(b)	Density of liquids	
600 kg/m^3 to 2000 kg/m^3		2.0 x 10^{-5}

5.33 Hydrometers

(a)	Density hydrometers	
(b)	Specific gravity hydrometers	
(c)	Brix hydrometers	
(d)	Proof spirit hydrometers	
600 kg/m^3 to 2000 kg/m^3		2.0 x 10^{-5}

5.35 Hygrometry

(a)	Humidity measuring devices	
i)	Dew point hygrometers	
-70 °C to 0 °C		0.2 °C to 0.06 °C
0 °C to 40 °C		0.06 °C
40 °C to 70 °C		0.06 °C to 0.12 °C
ii)	Relative humidity hygrometers	
10 % to 95 % (Temperature between 0 °C and 70 °C)		0.006 x *h* % *h* is relative humidity expressed as a percentage, that is % rh

iii) Dry bulb temperature

0 °C to 70 °C	0.1 °C

5.41 Barometers

(a) Aneroid barometers (including digital barometers)

50 kPa to 90 kPa	2.0×10^{-5}
90 kPa to 110 kPa	1.0×10^{-5}
110 kPa to 130 kPa	2.0×10^{-5}

5.42 Differential Pressure Measuring Devices (including Manometers)

(a) Diaphragm types
(b) Liquid column types, inclined and vertical
(c) Other types

1 Pa to 10000 Pa	$(6 \times 10^{-3} + 4.5 \times 10^{-5}\ p)$ Pa, p in Pa

5.43 Pressure Gauge Testers and Pressure Balances

i) Absolute pressure – gas medium

8 kPa to 550 kPa	2×10^{-5}
550 kPa to 7000 kPa	6×10^{-5}

ii) Gauge pressure – gas medium

-100 kPa to -10 kPa	1×10^{-4}
-10 kPa to -1 kPa	200 mPa to 100 mPa, decreasing linearly
1 kPa to 8 kPa	100 mPa to 160 mPa, increasing linearly
8 kPa to 550 kPa	2×10^{-5}
550 to 11000 kPa	6×10^{-5}

iii) Gauge pressure – liquid medium

0.1 MPa to 17 MPa	$(1 \times 10^{-4} + 6.6 \times 10^{-5} p)$ MPa (p in MPa)
17 MPa to 280 MPa	$(6.6 \times 10^{-5} p + 7 \times 10^{-7} p^2)$ MPa (p in MPa)

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5.44 Pressure and Vacuum Measurement

(a) Pressure gauges
(b) Vacuum gauges
(c) Pressure transducers
(d) Pressure recorders

i) Absolute pressure – gas medium

8 kPa to 90 kPa	2×10^{-5}
90 kPa to 110 kPa	1×10^{-5}
110 kPa to 550 kPa	2×10^{-5}
550 kPa to 7000 kPa	6×10^{-5}

ii) Gauge pressure – gas medium

-96 kPa to 8 kPa	0.0031 kPa
8 kPa to 90 kPa	2×10^{-5}
90 kPa to 110 kPa	1×10^{-5}
110 kPa to 550 kPa	2×10^{-5}
550 to 11000 kPa	6×10^{-5}

iii) Absolute pressure – liquid medium

0.3 MPa to 17 MPa	$(1 \times 10^{-4} + 6.6 \times 10^{-5} p)$ MPa (p in MPa)
17 MPa to 280 MPa	$(6.6 \times 10^{-5} p + 7 \times 10^{-7} p^2)$ MPa (p in MPa)

iv) Gauge pressure – liquid medium

0.2 MPa to 17 MPa	$(1 \times 10^{-4} + 6.6 \times 10^{-5} p)$ MPa (p in MPa)
17 MPa to 280 MPa	$(6.6 \times 10^{-5} p + 7 \times 10^{-7} p^2)$ MPa (p in MPa)

5.61 Temperature Measuring Equipment

(c) Platinum (and other metallic) resistance thermometers

i) Contact thermometers, including Standard PRTs at the following fixed points

Argon triple point (-189.3442 °C)	1 mK

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Mercury triple point (-38.8344 °C)	0.4 mK
Water triple point (0.01 °C)	0.1 mK
Gallium melting point (29.7646 °C)	0.19 mK
Indium freezing point (156.5985 °C)	0.56 mK
Tin freezing point (231.928 °C)	0.85 mK
Zinc freezing point 419.527 °C)	1.9 mK
Aluminium freezing point (660.323 °C)	10 mK

ii) Industrial PRTs and direct reading thermometers

-190 °C to <0 °C	(2.4 - 0.005 x *t*) mK, *t* in °C
0 °C to 200 °C	(2.4 + 0.008 x *t*) mK, *t* in °C
>200 °C to 550 °C	(4.0 + 0.03 x (*t* – 200)) mK, *t* in °C

5.65 Photometers and Radiometers

(a) Photometers

10 lux to 3000 lux	0.8 %

(b) Illuminance meters

0.005 lux to 10 lux	3 %
10 lux to 3000 lux	0.8 %

(c) Luminance meters

2 cd/m^2 to 800 cd/m^2	1.4 %
800 cd/m^2 to 27000 cd/m^2	7 %
27000 cd/m^2 to 33000 cd/m^2	11 %

(d) UV meters

240 nm to 250 nm	1.4 %
250 nm to 280 nm	1.4 % to 0.39 %, decreases linearly with wavelength
280 nm to <420 nm	0.39 %

(g) Laser power meters

Laser lines from 450 nm to 800 nm	0.022 %

(h) Detector spectral responsivity measurement

240 nm to 250 nm	1.4 %
250 nm to 280 nm	1.4 % to 0.39 %, decreases linearly with wavelength

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280 nm to <420 nm	0.39 %
420 nm to 680 nm	0.06 %
680 nm to 800 nm	0.08 %
800 nm to 950 nm	0.14 % to 0.16 %, varies with wavelength
Discrete wavelengths	
Laser lines from 450 nm to 800 nm	0.022 %

5.66 Lamps, LEDs, Lasers and Other Light Sources

Calibrations within 5.66 may be offered in the field as well as in the laboratory. An increase in uncertainty due to environmental conditions and other influence variables present in the field may need to be applied.

(a) Lamps: luminous intensity

10 cd to 5000 cd	0.8 %

(e) Illuminance

0.005 lux to 3000 lux	3 %

(f) General sources: spectral irradiance

250 nm to 350 nm	0.001 W/(m^2.nm) to 0.5 W/(m^2.nm)	2.6 % to 1.6 %
350 nm to 850 nm	0.001 W/(m^2.nm) to 0.5 W/(m^2.nm)	1.6 % to 1.4 %

(h) Photoluminescent materials

from 0.5 mcd/m^2	0.5 mcd/m^2 or 15 %, whichever is greater

5.67 Colour of Light Sources and Colorimeters

Calibrations within 5.67 may be offered in the field as well as in the laboratory. An increase in uncertainty due to environmental conditions and other influence variables present in the field may need to be applied.

(a) General sources:

Colour emitted in CIE x, y colour space	0.0005 to 0.005 in x and y, varies with measurand

Colour emitted in CIE u, v colour space		0.0007 in u and v
(d) Lamps:		
Correlated colour temperature 2700 K to 3000 K		5.4 K to 6.3 K, varies with measurand

5.68 Optical Properties of Materials: Spectral

(a) Regular transmittance and absorbance (bandwidth 1 nm to 3 nm)		
240 nm to 380 nm	0.01 to 1.0	0.5 % of value
380 nm to 1000 nm	0.0001 to 0.01	0.00005
380 nm to 1000 nm	0.01 to 0.1	0.00005 to 0.0001 varies with transmittance
380 nm to 1000 nm	0.1 to 1.0	0.1 % of value
(b) Wavelength calibration filters		
240 nm to 800 nm		0.13 nm
800 nm to 1100 nm		0.13 nm to 0.25 nm
(c) Diffuse transmittance		
300 nm to 400 nm		0.005 to 0.0002 or 5 % of value whichever is greater
400 nm to 1000 nm		0.0002 or 5 % of value whichever is greater
(d) Diffuse reflectance in 0/d and 6/d geometries		
360 nm to 820 nm	0.016 to 0.9	0.008 to 0.0036, varies with wavelength
360 nm to 820 nm	0.9 to 1.0	0.4 % of value
(e) Specular reflectance at normal incidence		
280 nm to 800 nm	0.05 to 1	1 % of value

5.69 Optical Properties of Materials: Spectrally integrated

(a) Luminous transmittance	
Spectrally flat materials	0.3 % of value
General materials	5 % of value

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(b)	Luminous reflectance	
General materials		5 % of value
(c)	Colour transmitted, x, y, Y or L*a*b*	
In x and y		0.005
Luminous transmittance Y for (0.1 < Y < 1)		5 % of value
(d)	Colour of surfaces, x, y, Y or L*a*b*	
In x and y		0.003
Luminance factor Y for (0.1 < Y < 1)		5 % of value
(e)	Retroreflectors: CIL value	
Coefficient of luminous intensity		5 %

5.70 Optical Instruments

(a)	Focal length	0.03 mm
(b)	Image plane principal point and nodal points	0.03 mm
	Nodal points	0.05 mm
(c)	Field of view	0.5 degrees

5.82 Resistors, Resistance Boxes and Potential Dividers

(a)	Precision resistors, resistance boxes and conductance boxes
0.1 Ω to 1 Ω (Current ≤ 100 mA)	0.2 μΩ/Ω
1 Ω to 10 kΩ (Power dissipation ≤ 10 mW)	0.12 μΩ/Ω
10 mΩ to 1000 mΩ (Current ≤ 1A)	25 μΩ/Ω
0.1 mΩ to 1000 mΩ (Current = 1 A to 875 A)	63 $R^{-0.35}$ μΩ/Ω, R in mΩ values range from 141 μΩ/Ω to 6 μΩ/Ω
0.01 MΩ to 1 MΩ (Applied voltages = 5 V to 100 V)	0.7 μΩ/Ω

0.001 GΩ to 1 GΩ (Applied voltages = 5 V to 100 V)	(0.7 + 27 R – 20 R^3) μΩ/Ω, R in GΩ, values range from 0.7 μΩ/Ω to 8 μΩ/Ω
1 MΩ to 5 TΩ (Applied voltages = 100 V to 1000 V)	(35 + 6.9 x 10^{-11} R^2 + 9.4 μΩ/Ω x $10^{-4}R$) μΩ/Ω, R in MΩ, values range from 35 μΩ/Ω to 6460 μΩ/Ω
0 MΩ to 1 MΩ (frequency, f = 40 Hz to 2 kHz)	(2000/f + 19 R) μΩ, f in Hz, R in Ω, values range from 1 μΩ to 19 Ω
0 Ω to 400 Ω (frequency, f = 0.01 Hz to 100 Hz)	(6 + 0.3 R) μΩ, R in Ω, values range from 6 μΩ to 126 μΩ
(b) Volt ratio boxes and potential dividers	
1 V/V to 1000 V/V (Input voltage ≤ 1100 V, output voltage ≥ 1 V)	0.4 x 10^{-6}
0 kV to 50 kV	3 mV/V
(c) DC shunts	
0.1 mΩ to 1 Ω (Applied current 1 A to 875 A) (Applied voltage 10 mV to 1 V)	63 $R^{-0.35}$ μΩ/Ω, R in mΩ values range from 141 μΩ/Ω to 6 μΩ/Ω
(d) AC shunts	
0 Ω to 100 Ω (frequency, f = 40 Hz to 2 kHz)	(2000/f + 19R) μΩ, f in Hz, R in Ω, values range from 1 μΩ to 1900 μΩ
0.2 A to 100 A (frequency, f = 47 Hz to 75 Hz)	25 μΩ/Ω
5.84 Capacitors	
(a) Precision capacitors	
0 μF to 100 μF (frequency, f = 40 Hz to 2 kHz)	(0.2/f + 22C) pF, f in Hz, C in μF, values range from 0.0001 pF to 2200 pF
Dissipation factor	

0 to 0.2 (frequency, *f* = 40 Hz to 2 kHz) (capacitance, *C* = 0.5 pF to 100 µF)	(0.000027 + 0.00027/*C*) *C* in pF, values range from 0.00057 to 0.000027
(c) Capacitance potential dividers	
1 kV rms to 35 kV rms (frequency, *f* = 50 Hz to 3 kHz)	1 mV/V

5.85 Inductors and Transformers

(a) Inductors, self and mutual	
0 H to 100 H (frequency, f = 40 Hz to 2 kHz)	(0.2/f + 14*L*)H µH, *f* in Hz *L* in H, values range from 0.0001 µH to 1400 µH
Equivalent series resistance 0 Ω to 1 MΩ (frequency, *f* = 40 Hz to 2 kHz)	(2000/*f* + 19*R*) µΩ, *f* in Hz, *R* in Ω, values range from 1 µΩ to 19 Ω
(d) Current transformers: protection and measurement	
Primary currents 1 A to 4000 A, ratios 0.2 A/A to 4000 A/A	
Ratio error -25 % to 25 % Phase error -36 crad to 36 crad (frequency, *f* = 50 Hz; secondary currents 1 A, 5 A)	0.0010 % to 0.13 % 0.0010 crad to 0.18 crad

5.86 Voltage Standards and Current Standards

(b) Electronic emf reference devices	
1 V 1.018 V 10 V	0.1 µV 0.1 µV 1.5 µV

5.87 Transfer Instruments (AC/DC)

0.002 V to 0.6 V > 0.6 V to 6 V > 6 V to 1000 V (frequency, *f* = 10 Hz to 1 MHz)	11 µV/V to 321 µV/V 6 µV/V to 77 µV/V 9 µV/V to 76 µV/V
1 V and 3 V (frequency, *f* = 1 MHz to 100 MHz)	0.16 mV/V to 2.6 mV/V

0.1 mA to 0.01 A (frequency, *f* = 40 Hz to 2 kHz)	15 µA/A to 38 µA/A
0.01 A to 20 A (frequency, *f* = 40 Hz to 100 kHz)	15 µA/A to 70 µA/A

5.88 Calibrators for Instrumentation

(a) DC voltage	
0 V to 12 V	(0.05 + 0.15*U*) µV, *U* in V, values range from 0.05 µV to 1.85 µV
12 V to 1100 V	0.5 µV/V
(b) AC voltage	
0.002 V to 1000 V (frequency, *f* = 10 Hz to 1 MHz)	6 µV/V to 650 µV/V
1 V and 3 V (frequency, *f* = 1 MHz to 100 MHz)	0.3 mV/V to 8 mV/V
(c) DC current	
1x10-11 A to 1x10-5 A	values range from 5 µA/A to 560 µA/A
0.01 mA to 0.1 mA	5 µA/A
>0.1 mA to 1 A	5 µA/A
>1 A to 20 A	5 $I^{0.43}$ µA/A, *I* in A, values range from 5 µA/A to 18µA/A
20 A to 1000 A	5 $I^{0.43}$ µA/A, *I* in A, values range from 18 µA/A to 97 µA/A
(d) AC current	
0.1 mA to 2 A (frequency, *f* = 40 Hz to 2 kHz)	35 µA/A to 170 µA/A
0.01 A to 100 A (frequency, *f* = 47 Hz to 75 Hz)	25 µA/A
(e) Resistance	
0 Ω to 10 Ω	40 µΩ
0.01 kΩ to 1 MΩ	3 µΩ/Ω
1 MΩ to 100 MΩ	(2 + $R^{0.8}$) µΩ/Ω, *R* in MΩ, values range from 3 µΩ/Ω to

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	42 µΩ/Ω

(f) AC power sources

Same as 5.89 (e) and (f)

5.89 Indicating Instruments and Recording Instruments

(a) DC voltmeters

0 V to 0.001 V	0.05 µV
0.001 V to 12 V	(0.05 + 0.15 *U*) µV, *U* in V, values range from 0.05 µV to 1.85 µV
12 V to 1100 V	0.5 µV/V

(b) AC voltmeters

0.002 V to 1000 V (frequency, *f* = 10 Hz to 1 MHz)	9 µV/V to 862 µV/V
1 V and 3 V (frequency, *f* = 1 MHz to 100 MHz)	0.3 mV/V to 8 mV/V

(c) DC ammeters

1x10-11 A to 1x10-5 A	values range from 5 µA/A to 560 µA/A
0.01 mA to 0.1 mA	5 µA/A
>0.1 mA to 1 A	5 µA/A
>1 A to 20 A	5 $I^{0.43}$ µA/A, I in A, values range from 5 µA/A to 18µA/A
20 A to 875 A	5 $I^{0.43}$ µA/A, I in A values range from 18 µA/A to 92 µA/A

(d) AC ammeters

0.1 mA to 2 A (frequency, *f* = 40 Hz to 2 kHz)	60 µA/A to 140 µA/A
0.2 A to 100 A (frequency, *f* = 47 Hz to 75 Hz)	25 µA/A

(e) Wattmeters

Conditions
Voltage 60 V to 240 V, current 0.01 A to 100 A, frequency 45 Hz to 75 Hz, and *PF* 1 to 0, inductive or capacitive

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Single phase 0 W to 24000 W	(40 µW/VA+ 6(1-*PF*)), values range from 40 µW/VA to 46 µW/VA
Three phase 0 W to 72000 W	(40 µW/VA + 6(1-*PF*)),values range from 40 µW/VA to 46 µW/VA

(The range and uncertainties for star and delta are the same as for single-phase)

(f) Varmeters

Conditions
Voltage 60 V to 240 V, current 0.01 A to 100 A, frequency 45 Hz to 75 Hz, and *QF* 1 to 0, inductive or capacitive

0 W to 24000 W	(40 µVar/VA + 90*QF),* values range from 40 µVar/VA to 130 µVar/VA
0 W to 72000 W	(40 µVar/VA + 90*QF),* values range from 40 µVar/VA to 130 µVar/VA

(g) Phase angle indicators (source or meter)

Conditions
Current 0.01 A to 100 A, frequency 45 Hz to 75 Hz, Voltage 0.7 V to 7 V, 42 V to 240 V

-3.14 rad to 3.14 rad	40 µrad

(h) Power factor meters

Same conditions, range and uncertainty as 5.89 (g) above

(i) Ohmmeters

0.1 mΩ to 1000 mΩ (applied current 875 A to 1 A)	$63R^{-0.35}$ µΩ, *R* in mΩ, values range from 141 µΩ to 6 µΩ
0.1 Ω to 1 Ω (applied current ≤100 mA)	0.2 µΩ/Ω
1 Ω to 10 kΩ	0.12 µΩ/Ω
10 kΩ to 1 GΩ	$(1 + 27R - 20R^{3)}$ µΩ/Ω, *R* in GΩ, values range from 1 µΩ/Ω to 8 µΩ/Ω

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1 GΩ to 100 GΩ	(-0.07R^2 + 22R -15) μΩ/Ω, R in GΩ, values range from 6.9 μΩ/Ω to 1485 μΩ/Ω
100 GΩ to 1200 GΩ	(1300R + 2.2R) μΩ/Ω, R in GΩ, values range from 1520 μΩ/Ω to 3940 μΩ/Ω

(k) Galvanometers and null detectors

Same range and least uncertainties from 5.89 (a) DC voltmeters

(l) Energy meters

Same as 5.89 (e) and (f)

5.90 Bridges, Potentiometers and Test Sets

(a) DC bridges

Same as 5.89 (i) Ohmmeters above

DC Bridges for thermometry

Resistance ratio 0 Ω/Ω to 13 Ω/Ω	2 x 10^{-8}

(b) DC potentiometers

Same as 5.89 (a) DC Voltmeters above

(c) AC bridges

0 Ω to 1 MΩ	(2000/f + 19R) μΩ, f in Hz, R in Ω, values range from 1 μΩ to 19 Ω
0 μF to 100 μF	(0.2/f + 22C) pF, f in Hz, C in μF, values range from 0.0001 pF to 2200 pF
0 H to 1 H	(0.2/f + 14L) H μH, f in Hz, L in H, values range from 0.0001 μH to 14 μH
(frequency, f = 40 Hz to 2 kHz)	

AC Bridges for thermometry

0 Ω/Ω to 13 Ω/Ω (frequency, f = 0 Hz to 100 Hz)	2 x 10^{-8}

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(f) Current transformer testing sets

Ratio/Phase
(frequencies in the range 45 Hz to 65 Hz)

Ratio error	± (0 to 0.002)	5.0×10^{-7} to 1.0×10^{-6}
Ratio error	± (0.002 to 0.02)	2.0×10^{-6} to 8.0×10^{-6}
Ratio error	± (0.02 to 0.2)	2.0×10^{-5} to 8.0×10^{-5}
Phase error	± 0 rad to 0.002 rad	5.0×10^{-7} rad to 1.0×10^{-6} rad
Phase error	± 0.002 rad to 0.02 rad	5.0×10^{-6} rad to 9.0×10^{-6} rad
Phase error	± 0.02 rad to 0.2 rad	5.0×10^{-5} rad to 9.0×10^{-5} rad

(g) Voltage transformer testing sets

Same as 5.90 (f)

5.91 Frequency Measurement and Time Measurement

Time and frequency Least Uncertainties relate only to the reference measuring systems. These uncertainties do not contain any contribution from the instrument under calibration.

(a) Frequency meters

1 Hz to 40 GHz	1×10^{-10}
0.001 Hz to 1 Hz (period)	1 ns

(c) Counters

1 Hz to 40 GHz	1×10^{-10}
0.001 Hz to 1 Hz (period)	1 ns

(d) Time interval meters

10 ns to 86400 s	2 ns or 2×10^{-13}, whichever is greatest

(e) Clocks and watches

5 ns to 1 s	50 ns

(g) Frequency standards

100 kHz to 10 MHz	2×10^{-13}
0.001 Hz to 1 Hz (period)	1 ns

(h) Time measurement

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Time scale difference – Local clock vs UTC (MSL) -1 s to 1 s	2 ns
Time scale difference – Local clock vs UTC -1 s to 1 s	50 ns

5.92 Waveform Measurement

(a) Frequency characteristics

1 Hz to 20 MHz 0.001 Hz to 1 Hz (period)	1 in 10^{-10} 1 ns

(b) Input characteristics

1 V and 3 V (frequency, f = 1 MHz to 100 MHz)	0.16 mV/V to 2.6 mV/V
Pulse risetime (T>5 ns) (10 mV to 10 V)	
0.005 µs to 1.00 x 10^{6} µs	Q(2 ns, 0.05T), T in s
Pulse amplitude (pulse length > 200 µs) (10 mV, 100 mV, 1 V, 10 V)	
0 V to 10 V	(30 µV+ 100Va + 420Vr), applied voltage Va in V, voltmeter range Vr in V, values range from 34.2 µV to 5230 µV

(c) Timing characteristics

10 ns to 100 s (time difference)	2 ns

5.93 Signal Sources

(a) Frequency characteristics

1 Hz to 20 MHz 0.001 Hz to 1 Hz (period)	1 x 10^{-10} 1 ns

(b) Output characteristics

1 V and 3 V (frequency, *f* = 1 MHz to 100 MHz)	0.16 mV/V to 2.6 mV/V
Pulse amplitude (pulse length > 200 µs) (10 mV, 100 mV, 1 V, 10 V)	
0 V to 10 V	(30 µV + 100*Va* + 420*Vr*) applied voltage *Va* in V, voltmeter range *Vr* in V, values range from 34.2 µV to 5230 µV
Pulse risetime (*T* > 5 ns) (10 mV to 10 V)	
0.005 µs to 1.00 x 10^6 µs	Q(2 ns, 0.05*T*), *T* in s
RF power (absolute) 0.1 mW to 10 mW (frequency range from 10 MHz to 2.5 GHz)	0.0026 mW/mW
Reflection coefficient -1.0 to 1.0 (frequency range from 10 MHz to 2.5 GHz)	0.0050

5.95 Communications Equipment

(h) Power measuring equipment

Calibration factor Values from 0.1 to 1.2 (frequency range 10 MHz to 18 GHz, power level -15 dBm to 10 dBm)	0.004 to 0.012

(i) Attenuators and amplifiers
(j) Waveguide and coaxial components

Measurement of reflection coefficient for coaxial components in the range 30 kHz to 18 GHz

Complex reflection coefficient with magnitude between 0 and 1

Nominal magnitude (linear)	Least uncertainty of measurement (real or imaginary component)
1.0	0.002 to 0.017
0.9	0.002 to 0.015
0.8	0.002 to 0.013
0.7	0.002 to 0.011
0.6	0.003 to 0.010

0.5	0.003 to 0.010
0.4	0.003 to 0.009
0.3	0.003 to 0.009
0.2	0.004 to 0.008
0.1	0.004 to 0.008
0.0	0.004 to 0.008 (increases with frequency)

Reflection coefficient magnitude between 0 and 1

Nominal magnitude (linear)	Least uncertainty of measurement (magnitude)
1.0	0.002 to 0.017
0.9	0.002 to 0.015
0.8	0.002 to 0.013
0.7	0.002 to 0.011
0.6	0.003 to 0.010
0.5	0.003 to 0.010
0.4	0.003 to 0.009
0.3	0.003 to 0.009
0.2	0.004 to 0.008
0.1	0.004 to 0.008
0.0	0.004 to 0.008 (increases with frequency)

Reflection coefficient phase between -180° and 180°

Nominal magnitude (linear)	Least uncertainty of measurement (phase)
1.0	0.1° to 1.0°
0.9	0.1° to 1.0°
0.8	0.2° to 1.0°
0.7	0.2° to 1.0°
0.6	0.3° to 1.0°
0.5	0.3° to 1.1°
0.4	0.5° to 1.3°
0.3	0.6° to 1.7°
0.2	1.0° to 2.4°
0.1	2.1° to 4.7°
0.0	180° (increases with frequency)

Measurement of transmission coefficient for coaxial components in the range 30 kHz to 100 kHz

Complex transmission coefficient with magnitude between 0 and 1

Nominal magnitude (linear)	Least uncertainty of measurement (relative uncertainty of real or imaginary

	component)
1.000	0.003
0.708	0.004
0.500	0.004
0.230	0.004
0.100	0.004
0.032	0.005
0.010	0.008 to 0.006
0.003	0.018 to 0.006
0.001	0.050 to 0.009 (decreases with increasing frequency)

Transmission coefficient magnitude between 0 and 60 dB

Nominal magnitude (log)	Least uncertainty of measurement (magnitude)
0 dB	0.03 dB
3 dB	0.03 dB
6 dB	0.03 dB
10 dB	0.03 dB
20 dB	0.04 dB
30 dB	0.05 dB to 0.04 dB
40 dB	0.07 dB to 0.05 dB
50 dB	0.15 dB to 0.06 dB
60 dB	0.42 dB to 0.08 dB (decreases with increasing frequency)

Transmission coefficient phase between -180° and 180°

Nominal magnitude (log)	Least uncertainty of measurement (phase)
0 dB	0.2°
3 dB	0.2°
6 dB	0.2°
10 dB	0.2°
20 dB	0.3°
30 dB	0.3°
40 dB	0.4° to 0.3°
50 dB	1.0° to 0.4°
60 dB	2.9° to 0.5° (decreases with increasing frequency)

Measurement of transmission coefficient for coaxial components in the range 100 kHz to 18 GHz

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Complex transmission coefficient with magnitude between 0 and 1

Nominal magnitude (linear)	Least uncertainty of measurement (relative uncertainty of real or imaginary component)
1.000	0.003 to 0.005
0.708	0.004 to 0.005
0.500	0.004 to 0.005
0.230	0.004 to 0.005
0.100	0.004 to 0.006
0.032	0.005 to 0.006
0.010	0.006 to 0.007
0.003	0.006 to 0.009
0.001	0.009 to 0.011 (increases with frequency)

Transmission coefficient magnitude between 0 dB and 60 dB

Nominal magnitude (log)	Least uncertainty of measurement (magnitude)
0 dB	0.03 dB to 0.04 dB
3 dB	0.03 dB to 0.04 dB
6 dB	0.03 dB to 0.05 dB
10 dB	0.03 dB to 0.05 dB
20 dB	0.04 dB to 0.05 dB
30 dB	0.05 dB
40 dB	0.05 dB to 0.06 dB
50 dB	0.06 dB to 0.08 dB
60 dB	0.08 dB to 0.10 dB (increases with frequency)

Transmission coefficient phase between -180° and 180°

Nominal magnitude (log)	Least uncertainty of measurement (phase)
0 dB	0.2° to 0.3°
3 dB	0.2° to 0.3°
6 dB	0.2° to 0.3°
10 dB	0.2° to 0.3°
20 dB	0.3°
30 dB	0.3° to 0.4°
40 dB	0.3° to 0.4°
50 dB	0.4° to 0.5°
60 dB	0.5° to 0.6° (increases with frequency)

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5.97 High Voltage Testing

(a) Direct voltage

0 kV to 50 kV	3 mV/V

(b) Alternating voltage

1 kV rms to 35 kV rms (frequency, *f* = 50 Hz to 3 kHz)	1 mV/V

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